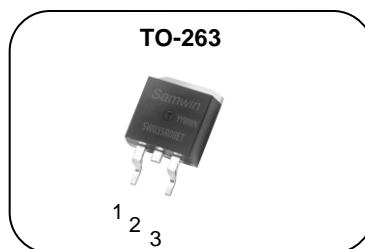
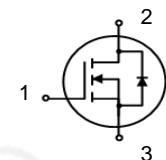


**N-channel Enhanced mode TO-263 MOSFET****Features**

- High ruggedness
- Low  $R_{DS(ON)}$  (Typ 3.3mΩ)@ $V_{GS}=10V$
- Low Gate Charge (Typ 185nC)
- Improved dv/dt Capability
- 100% Avalanche Tested
- Application: Synchronous Rectification, Inverter, Li Battery Protect Board

**1. Gate 2. Drain 3. Source**

$BV_{DSS}$ : 80V
$I_D$ : 120A
$R_{DS(ON)}$ : 3.3mΩ

**General Description**

This power MOSFET is produced with advanced technology of SAMWIN.

This technology enable the power MOSFET to have better characteristics, including fast switching time, low on resistance, low gate charge and especially excellent avalanche characteristics.

**Order Codes**

Item	Sales Type	Marking	Package	Packaging
1	SW B 035R08ET	SW035R08ET	TO-263	TUBE

**Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain to source voltage	80	V
$I_D$	Continuous drain current (@ $T_C=25^\circ C$ )	120*	A
	Continuous drain current (@ $T_C=100^\circ C$ )	100*	A
$I_{DM}$	Drain current pulsed (note 1)	480	A
$V_{GS}$	Gate to source voltage	$\pm 20$	V
$E_{AS}$	Single pulsed avalanche energy (note 2)	2349	mJ
$E_{AR}$	Repetitive avalanche energy (note 1)	58	mJ
dv/dt	Peak diode recovery dv/dt (note 3)	5	V/ns
$P_D$	Total power dissipation (@ $T_C=25^\circ C$ )	196	W
	Derating factor above 25°C	1.6	W/°C
$T_{STG}, T_J$	Operating junction temperature & storage temperature	-55 ~ + 150	°C
$T_L$	Maximum lead temperature for soldering purpose, 1/8 from case for 5 seconds.	300	°C

\*. Drain current is limited by junction temperature.

**Thermal characteristics**

Symbol	Parameter	Value	Unit
$R_{thjc}$	Thermal resistance, Junction to case	0.64	°C/W

Electrical characteristic ( $T_C = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
<b>Off characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain to source breakdown voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=250\mu\text{A}$	80			V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown voltage temperature coefficient	$I_D=250\mu\text{A}$ , referenced to $25^\circ\text{C}$		0.03		$\text{V}/^\circ\text{C}$
$I_{\text{DSS}}$	Drain to source leakage current	$V_{\text{DS}}=80\text{V}$ , $V_{\text{GS}}=0\text{V}$		1		$\mu\text{A}$
		$V_{\text{DS}}=64\text{V}$ , $T_C=125^\circ\text{C}$		50		$\mu\text{A}$
$I_{\text{GSS}}$	Gate to source leakage current, forward	$V_{\text{GS}}=20\text{V}$ , $V_{\text{DS}}=0\text{V}$		100		nA
	Gate to source leakage current, reverse	$V_{\text{GS}}=-20\text{V}$ , $V_{\text{DS}}=0\text{V}$		-100		nA
<b>On characteristics</b>						
$V_{\text{GS(TH)}}$	Gate threshold voltage	$V_{\text{DS}}=V_{\text{GS}}$ , $I_D=250\mu\text{A}$	2		4	V
$R_{\text{DS(ON)}}$	Drain to source on state resistance	$V_{\text{GS}}=10\text{V}$ , $I_D=60\text{A}$		3.3	4.1	$\text{m}\Omega$
		$V_{\text{GS}}=10\text{V}$ , $I_D=120\text{A}$		3.4	4.3	$\text{m}\Omega$
$G_{\text{fs}}$	Forward transconductance	$V_{\text{DS}}=8\text{V}$ , $I_D=60\text{A}$	170			S
<b>Dynamic characteristics</b>						
$C_{\text{iss}}$	Input capacitance	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=40\text{V}$ , $f=1\text{MHz}$		8130		pF
$C_{\text{oss}}$	Output capacitance			885		
$C_{\text{rss}}$	Reverse transfer capacitance			732		
$t_{\text{d(on)}}$	Turn on delay time	$V_{\text{DS}}=40\text{V}$ , $I_D=30\text{A}$ , $R_G=25\Omega$ , $V_{\text{GS}}=10\text{V}$ (note 4,5)		84		ns
$t_r$	Rising time			218		
$t_{\text{d(off)}}$	Turn off delay time			388		
$t_f$	Fall time			253		
$Q_g$	Total gate charge	$V_{\text{DS}}=64\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $I_D=30\text{A}$ (note 4,5)		185		nC
$Q_{\text{gs}}$	Gate-source charge			24		
$Q_{\text{gd}}$	Gate-drain charge			87		
$R_g$	Gate resistance	$V_{\text{DS}}=0\text{V}$ , Scan F mode	1.5			$\Omega$

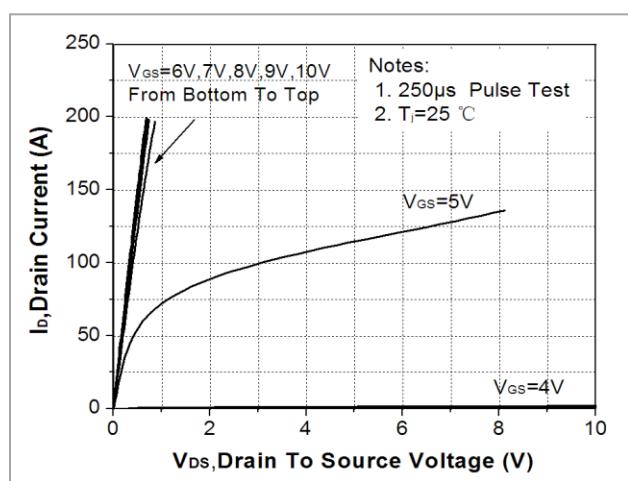
## Source to drain diode ratings characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous source current	Integral reverse p-n Junction diode in the MOSFET			120	A
$I_{\text{SM}}$	Pulsed source current				480	A
$V_{\text{SD}}$	Diode forward voltage drop.	$I_s=60\text{A}$ , $V_{\text{GS}}=0\text{V}$			1.4	V
$t_{\text{rr}}$	Reverse recovery time	$I_s=30\text{A}$ , $V_{\text{GS}}=0\text{V}$ , $dI_F/dt=100\text{A}/\mu\text{s}$		50		ns
$Q_{\text{rr}}$	Reverse recovery charge			70		nC

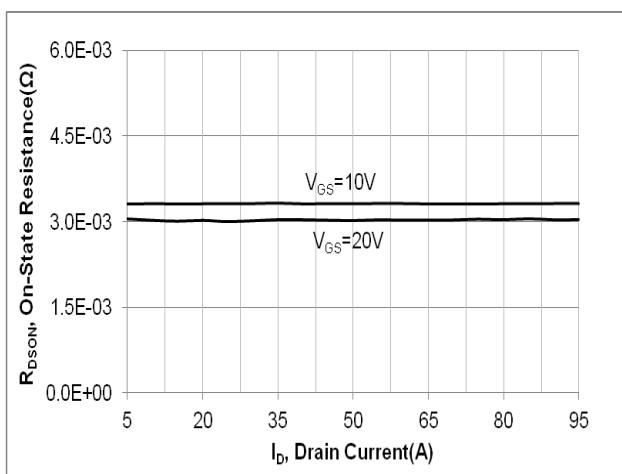
※. Notes

1. Repetitive rating : pulse width limited by junction temperature.
2.  $L = 5.2\text{mH}$ ,  $I_{\text{AS}} = 30\text{A}$ ,  $V_{\text{DD}} = 50\text{V}$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{\text{SD}} \leq 30\text{A}$ ,  $dI/dt = 100\text{A}/\mu\text{s}$ ,  $V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
5. Essentially independent of operating temperature.

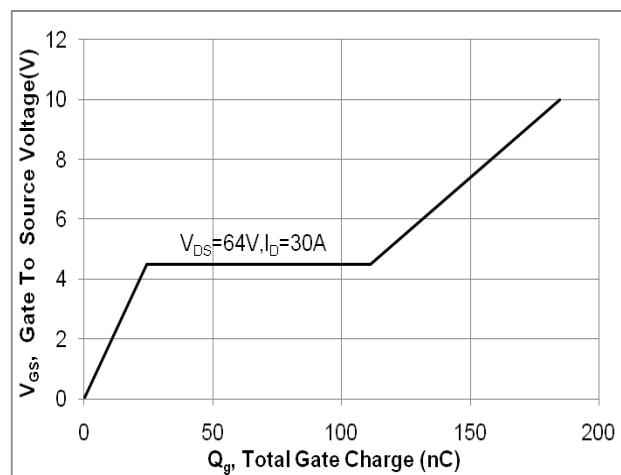
**Fig. 1. On-state characteristics**



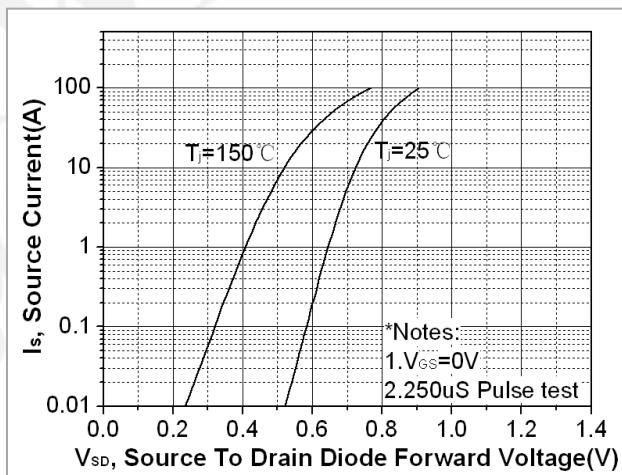
**Fig. 2. On-resistance variation vs. drain current and gate voltage**



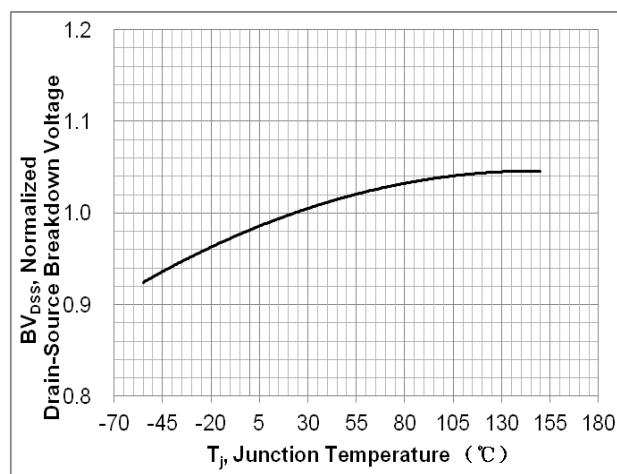
**Fig. 3. Gate charge characteristics**



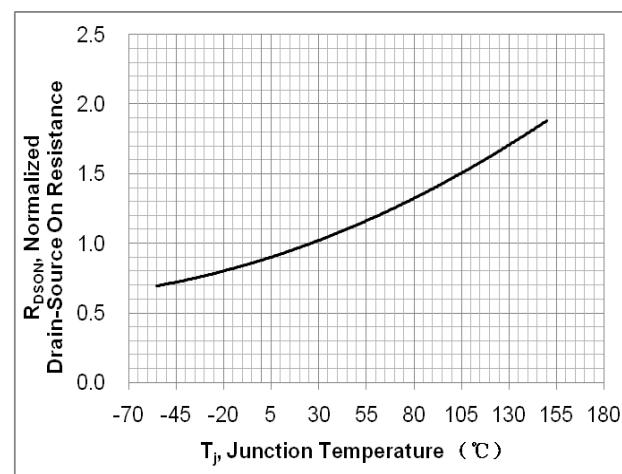
**Fig. 4. On-state current vs. diode forward voltage**



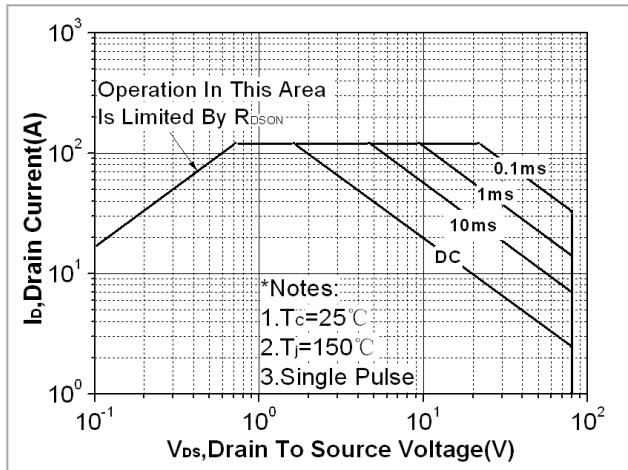
**Fig. 5. Breakdown voltage variation vs. junction temperature**



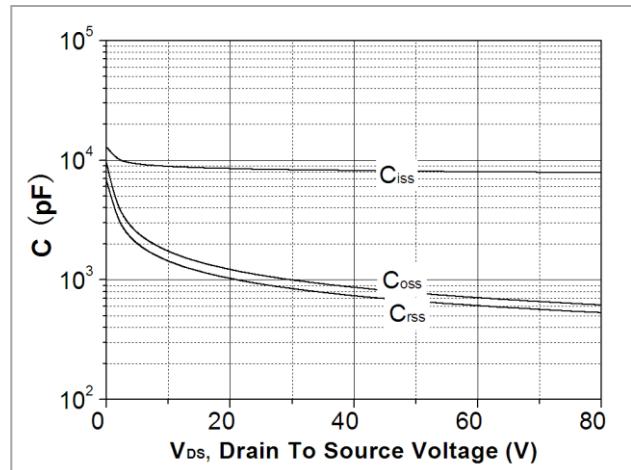
**Fig. 6. On-resistance variation vs. junction temperature**



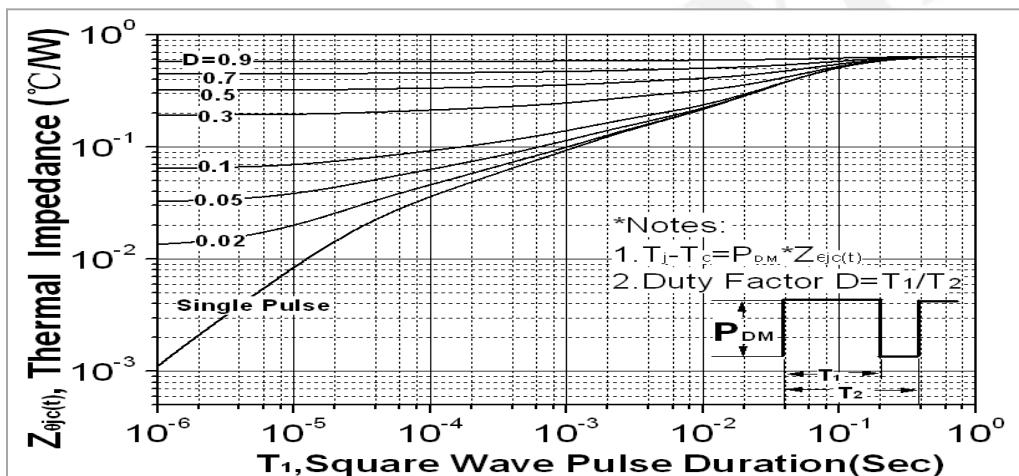
**Fig. 7. Maximum safe operating area**



**Fig. 8. Capacitance Characteristics**



**Fig. 9. Transient thermal response curve**



**Fig. 10. Gate charge test circuit & waveform**

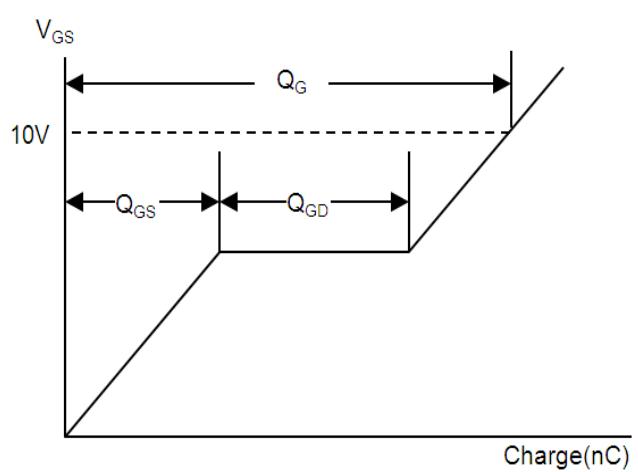
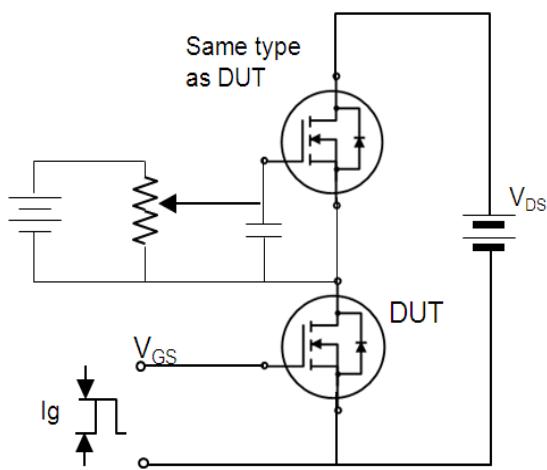


Fig. 11. Switching time test circuit & waveform

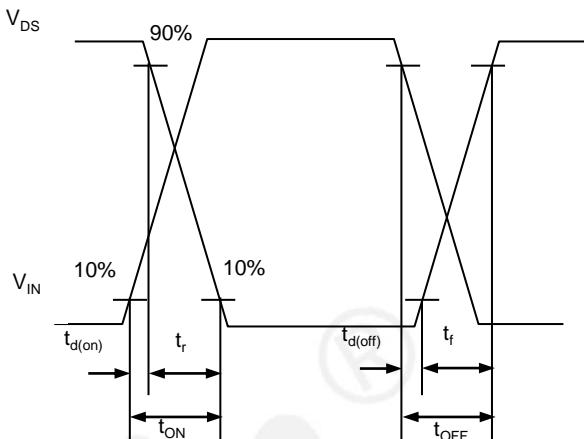
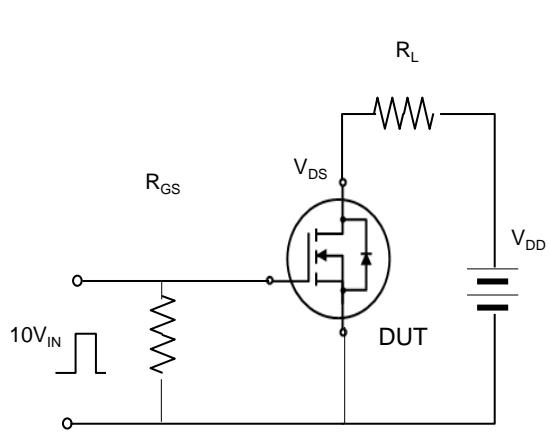
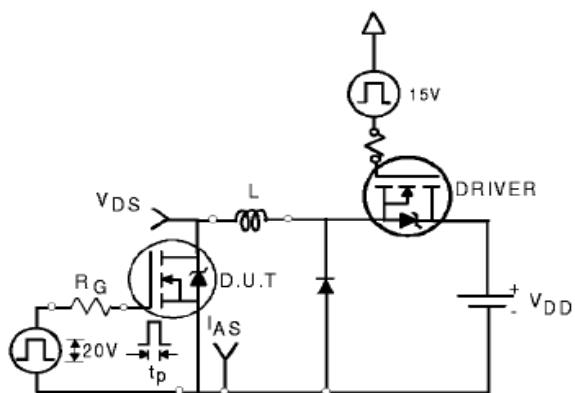


Fig. 12. Unclamped Inductive switching test circuit & waveform



$$E_{AS} = \frac{1}{2} L I_{AS}^2$$

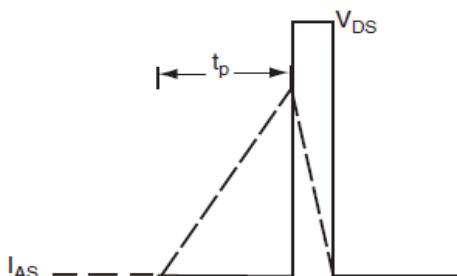
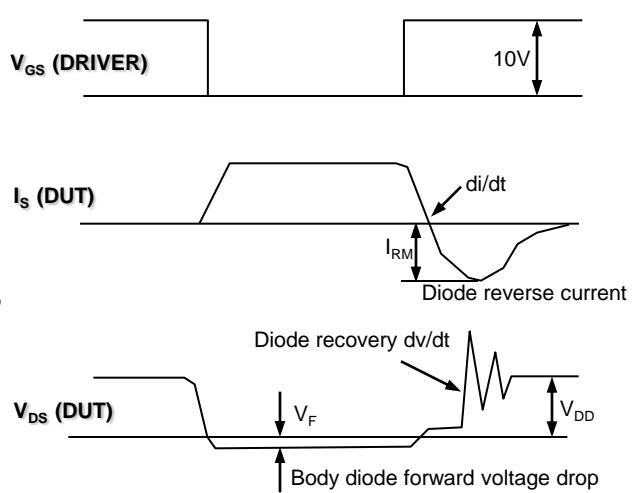
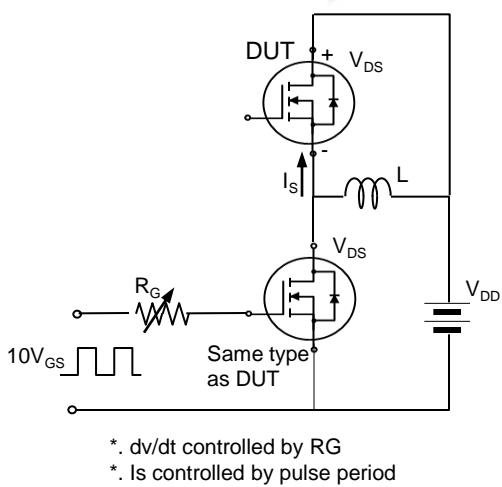


Fig. 13. Peak diode recovery dv/dt test circuit & waveform



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## DISCLAIMER

- \* All the data & curve in this document was tested in XI'AN SEMIPOWER TESTING & APPLICATION CENTER.
- \* This product has passed the PCT,TC,HTRB,HTGB,HAST,PC and Solderdunk reliability testing.
- \* Qualification standards can also be found on the Web site (<http://www.semipower.com.cn>) 
- \* Suggestions for improvement are appreciated, Please send your suggestions to [samwin@samwinsemi.com](mailto:samwin@samwinsemi.com)